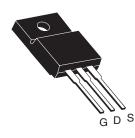


IRFIZ34VPBF-VB Datasheet N-Channel 60 V (D-S) MOSFET

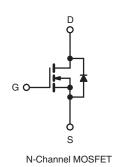
PRODUCT SUMMARY						
V _{DS} (V)	60					
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.027				
Q _g (Max.) (nC)	95					
Q _{gs} (nC)	27					
Q _{gd} (nC)	46					
Configuration	Single					

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available



TO-220 FULLPAK



ABSOLUTE MAXIMUM RATINGS	_C = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	60	v		
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	45		
	VGS at 10 V	$T_C = 100 \ ^\circ C$		30	А	
Pulsed Drain Current ^a			I _{DM}	220		
Linear Derating Factor			0.32	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	52	W	
Peak Diode Recovery dV/dt ^c			dV/dt 4.5		V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 129 µH, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \le 52 \text{ A}$, dl/dt $\le 250 \text{ A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.

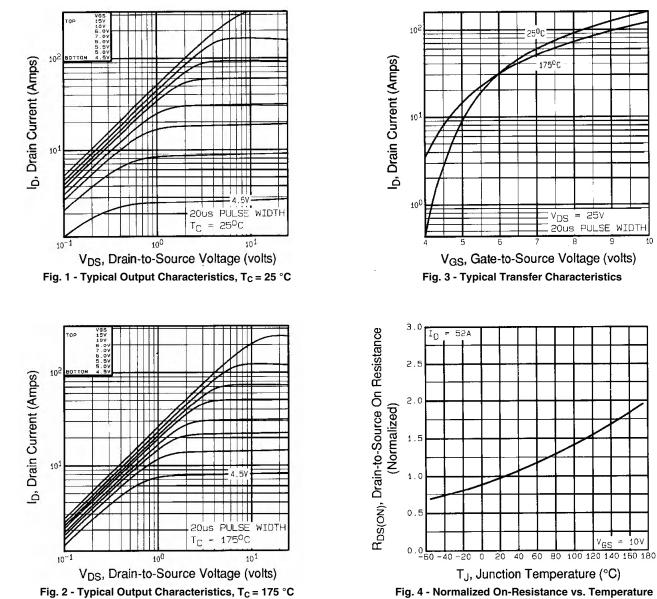
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THERMAL RESISTANCE RAT	TINGS								
PARAMETER	SYMBOL	TYP	•	MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65							
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherw	vise noted				1			
PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNIT	
Static								-	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$			60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.060	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			1.0	-	3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 V$			-	-	± 100	nA	
Zero Gate Voltage Drain Current	laas	V _{DS} =	= 60 V, V _{GS}	= 0 V	-	-	25		
	I _{DSS}	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$			-	-	250	μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 18 A ^b	-	0.027	-	Ω	
Forward Transconductance	g _{fs}	V _{DS} =	= 25 V, I _D =	18 A ^b	15	-	-	S	
Dynamic									
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	1500	-			
Output Capacitance	C _{oss}		$V_{DS} = 25 V$,	-	720	-	1	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	100	-	pF		
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg				-	-	95	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		52 A, V _{DS} = 48 V, e fig. 6 and 13 ^b	-	-	27		
Gate-Drain Charge	Q _{gd}	See no		g. 6 and 13-	-	-	46		
Turn-On Delay Time	t _{d(on)}		•		-	19	-		
Rise Time	t _r	$\label{eq:V_DD} \begin{array}{l} {\sf V}_{\rm DD} = 30 \ {\sf V}, \ {\sf I}_{\rm D} = 52 \ {\sf A}, \\ {\sf R}_{\rm G} = 9.1 \ \Omega, \ {\sf R}_{\rm D} = 0.54 \ \Omega, \\ {\sf see \ fig. \ 10^b} \end{array}$		-	120	-	ns		
Turn-Off Delay Time	t _{d(off)}			-	55	-			
Fall Time	t _f			-	86	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L _S			-	7.5	-			
Drain-Source Body Diode Characteristic	s				-				
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	45	A		
Pulsed Diode Forward Currenta	I _{SM}	integral reverse of the second			-	-		120	
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 30 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^{\circ}C, \ I_F = 52 \ A, \ dI/dt = 100 \ A/\mu s^b$		-	140	300	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.8	μC		
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	is negligible (turn	on is dor	ninated by	/ L _S and I	_D)	

Notes

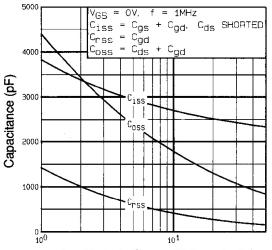
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

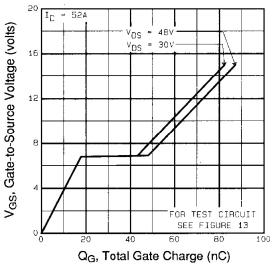


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

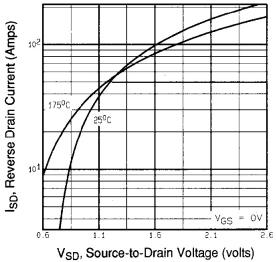
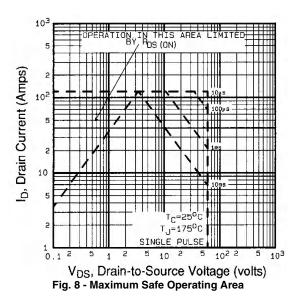


Fig. 7 - Typical Source-Drain Diode Forward Voltage



IRFIZ34VPBF-VB



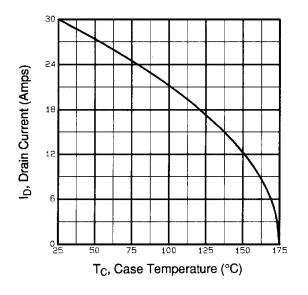


Fig. 9 - Maximum Drain Current vs. Case Temperature

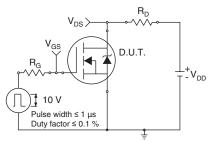


Fig. 10a - Switching Time Test Circuit

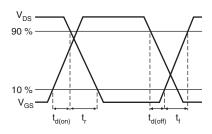


Fig. 10b - Switching Time Waveforms

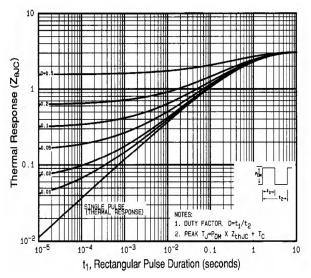
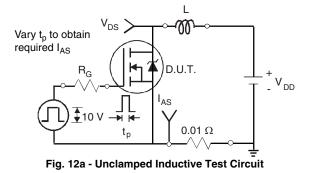


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



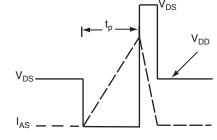
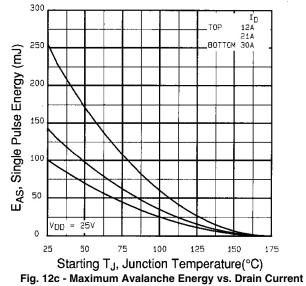
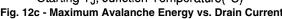


Fig. 12b - Unclamped Inductive Waveforms







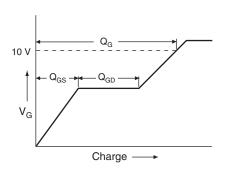
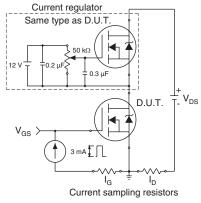
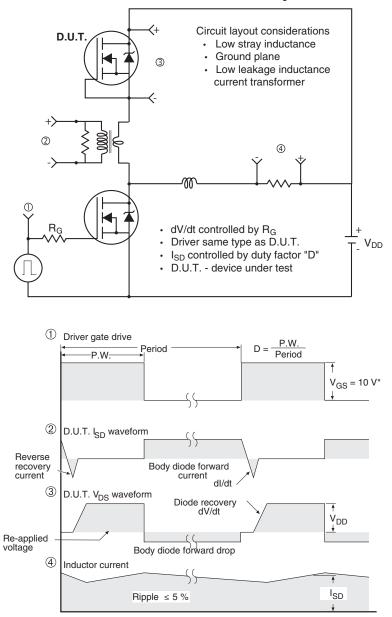


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



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